

STN search for10/622488

STN Database
Search

Connecting via Winsock to STN

Welcome to STN International! Enter x:x

LOGINID:sssptau156cxh

PASSWORD:

TERMINAL (ENTER 1, 2, 3, OR ?):2

* * * * * Welcome to STN International * * * * *

NEWS 1 Web Page URLs for STN Seminar Schedule - N. America
NEWS 2 "Ask CAS" for self-help around the clock
NEWS 3 Jul 12 BEILSTEIN enhanced with new display and select options,
resulting in a closer connection to BABS
NEWS 4 AUG 02 IFIPAT/IFIUDB/IFICDB reloaded with new search and display
fields
NEWS 5 AUG 02 Caplus and CA patent records enhanced with European and Japan
Patent Office Classifications
NEWS 6 AUG 02 The Analysis Edition of STN Express with Discover!
(Version 7.01 for Windows) now available
NEWS 7 AUG 27 BIOCOMMERCE: Changes and enhancements to content coverage
NEWS 8 AUG 27 BIOTECHABS/BIOTECHDS: Two new display fields added for legal
status data from INPADOC
NEWS 9 SEP 01 INPADOC: New family current-awareness alert (SDI) available
NEWS 10 SEP 01 New pricing for the Save Answers for SciFinder Wizard within
STN Express with Discover!
NEWS 11 SEP 01 New display format, HITSTR, available in WPIDS/WPINDEX/WPIX
NEWS 12 SEP 27 STANDARDS will no longer be available on STN
NEWS 13 SEP 27 SWETSCAN will no longer be available on STN

NEWS EXPRESS JULY 30 CURRENT WINDOWS VERSION IS V7.01, CURRENT
MACINTOSH VERSION IS V6.0c(ENG) AND V6.0Jc(JP),
AND CURRENT DISCOVER FILE IS DATED 11 AUGUST 2004
NEWS HOURS STN Operating Hours Plus Help Desk Availability
NEWS INTER General Internet Information
NEWS LOGIN Welcome Banner and News Items
NEWS PHONE Direct Dial and Telecommunication Network Access to STN
NEWS WWW CAS World Wide Web Site (general information)

Enter NEWS followed by the item number or name to see news on that
specific topic.

All use of STN is subject to the provisions of the STN Customer
agreement. Please note that this agreement limits use to scientific
research. Use for software development or design or implementation
of commercial gateways or other similar uses is prohibited and may
result in loss of user privileges and other penalties.

* * * * * STN Columbus * * * * *

FILE 'HOME' ENTERED AT 10:55:31 ON 26 OCT 2004

=> file caplus

COST IN U.S. DOLLARS

SINCE FILE

TOTAL

Page 1by Examiner Cynthia Hamilton

STN search for 10/622488

FULL ESTIMATED COST

ENTRY

SESSION

0.21

0.21

FILE 'CAPLUS' ENTERED AT 10:55:46 ON 26 OCT 2004
USE IS SUBJECT TO THE TERMS OF YOUR STN CUSTOMER AGREEMENT.
PLEASE SEE "HELP USAGETERMS" FOR DETAILS.
COPYRIGHT (C) 2004 AMERICAN CHEMICAL SOCIETY (ACS)

Copyright of the articles to which records in this database refer is held by the publishers listed in the PUBLISHER (PB) field (available for records published or updated in Chemical Abstracts after December 26, 1996), unless otherwise indicated in the original publications. The CA Lexicon is the copyrighted intellectual property of the American Chemical Society and is provided to assist you in searching databases on STN. Any dissemination, distribution, copying, or storing of this information, without the prior written consent of CAS, is strictly prohibited.

FILE COVERS 1907 - 26 Oct 2004 VOL 141 ISS 18
FILE LAST UPDATED: 25 Oct 2004 (20041025/ED)

This file contains CAS Registry Numbers for easy and accurate substance identification.

=> s (multiphoton or multiple photon)

13402 MULTIPHOTON

335822 MULTIPLE

116796 PHOTON

955 MULTIPLE PHOTON

(MULTIPLE(W) PHOTON)

L1 13877 (MULTIPHOTON OR MULTIPLE PHOTON)

=> s l1 and refractive

67040 REFRACTIVE

L2 81 L1 AND REFRACTIVE

=> s l1 and refract?

208965 REFRACT?

L3 109 L1 AND REFRACT?

=> s l3 and visible

287748 VISIBLE

L4 11 L3 AND VISIBLE

=> d all 1-11

L4 ANSWER 1 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN

AN 2003:138225 CAPLUS

DN 138:408809

ED Entered STN: 24 Feb 2003

TI Multiphoton absorption of solutions of polydiacetylene

polyDCHD-HS measured using ps Z-scan at 1064 and 1500 nm

AU Giorgetti, Emilia; Toci, Guido; Vannini, Matteo; Giammanco, Francesco

CS Istituto di Fisica Applicata "Nello Carrara" -CNR, Florence, 50127, Italy

SO Optics Communications (2003), 217(1-6), 431-439

CODEN: OPCOB8; ISSN: 0030-4018

PB Elsevier Science B.V.

DT Journal

STN search for 10/622488

LA English
CC 73-10 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
AB The nonlinear absorption of benzene and toluene solns. of polydiacetylene polyDCHD-HS was measured at $\lambda=1064$ and 1500 nm by using Z-scan and picosecond pulses with a trimmed Airy beam configuration. In the data anal., the authors took into account both the saturation of the open aperture Z-scan traces occurring for high values of nonlinear absorption and the possible occurrence of cross-talk effects between nonlinear refraction and multiphoton absorption. The polymer exhibits three-photon absorption at both 1064 and 1500 nm. The mol. three-photon absorption coefficient at 1064 nm was $\sigma_3=1.8 + 10^{-38}$ cm⁶/W² and $\sigma_3=2.3 + 10^{-38}$ cm⁶/W² in toluene and benzene, resp., while at 1500 nm it was $\sigma_3=1.5 + 10^{-39}$ cm⁶/W² in toluene. On this basis, the optical limiting behavior of polyDCHD-HS in the near IR range is also shown.
ST multiphoton absorption polydiacetylene Z scan optical limiting
IT Multiphoton absorption
Nonlinear optical absorption
Optical limiting
UV and visible spectra
(multiphoton absorption of solns. of polydiacetylene polyDCHD-HS measured using ps Z-scan at 1064 and 1500 nm)
IT Polydiacetylenes
RL: PRP (Properties)
(multiphoton absorption of solns. of polydiacetylene polyDCHD-HS measured using ps Z-scan at 1064 and 1500 nm)
IT 71-43-2, Benzene, uses 108-88-3, Toluene, uses
RL: NUU (Other use, unclassified); USES (Uses)
(multiphoton absorption of solns. of polydiacetylene polyDCHD-HS in benzene or toluene solution)
IT 175736-86-4
RL: PRP (Properties)
(multiphoton absorption of solns. of polydiacetylene polyDCHD-HS measured using ps Z-scan at 1064 and 1500 nm)
RE.CNT 29 THERE ARE 29 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE
(1) Alloisio, M; J Chem Soc, Perkin Trans 2 2001, P2
(2) Banfi, G; J Chem Phys 1998, V108, P4319 CAPLUS
(3) Boyle, A; Handbook of Advanced Electronic and Photonic Materials 2001, V9 CAPLUS
(4) Burzler, J; Appl Phys B 1995, V62, P389
(5) Charra, F; J Opt Soc Am B 1991, V8, P570 CAPLUS
(6) Colombi, C; Macromol Chem Phys 1996, V197, P1241 CAPLUS
(7) Cravino, A; Syn Met 1999, V102(1-3), P943 CAPLUS
(8) D'Amore, F; Syn Met 2002, V127, P143 CAPLUS
(9) Giorgetti, E; Phys Chem Chem Phys 2002, V4, P2762 CAPLUS
(10) Grando, D; Chem Phys Lett 2002, V363, P492 CAPLUS
(11) He, G; Opt Lett 1995, V20, P1524 CAPLUS
(12) Hughes, S; J Opt Soc Am B 1995, V12, P1888 CAPLUS
(13) Lawrence, B; Phys Rev Lett 1994, V73, P597 CAPLUS
(14) Liu, M; Multiphoton and Light Driven Multielectron Processes in Organics: New Phenomena Materials and Applications 2000
(15) Margheri, G; J Opt Soc Am B in press 2002
(16) Moroni, L; J Phys Chem A 2001, V105, P7759 CAPLUS
(17) Nunzi, J; J Appl Phys 1987, V62, P2198 CAPLUS
(18) Nunzi, J; Nonlinear Opt 1991, V1, P19 CAPLUS
(19) Pender, W; Appl Phys Lett 1995, V66, P786 CAPLUS
(20) Perry, J; Science 1996, V273, P1533 CAPLUS
(21) Polyakov, S; J Opt Soc Am B 2001, V18, P1891 CAPLUS

STN search for 10/622488

- (22) Rhee, B; J Opt Soc Am B 1996, V13, P2720 CAPLUS
- (23) Sauteret, C; Phys Rev Lett 1976, V36, P956 CAPLUS
- (24) Sheik-Bahae, M; IEEE J Quantum Electron 1990, V26, P760 CAPLUS
- (25) Shim, H; Opt Lett 1998, V23, P430 CAPLUS
- (26) Sottini, S; Recent Res Dev Quantum Electron 2000, V2, P85 CAPLUS
- (27) Stegeman, G; Phil Trans R Soc Lond A 1996, V354, P745 CAPLUS
- (28) Toci, G; Appl Phys B 2000, V71, P907 CAPLUS
- (29) Zhan, C; J Opt Soc Am B 2002, V19, P369 CAPLUS

L4 ANSWER 2 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2003:81478 CAPLUS
DN 138:328164
ED Entered STN: 03 Feb 2003
TI Optical properties of femtosecond irradiated photo-thermo-
refractive glass
AU Juodkazis, S.
CS Institute of Materials Science and Applied Research, Vilnius University,
Vilnius, 2040, Lithuania
SO Lithuanian Journal of Physics (2002), 42(2), 119-126
CODEN: LJPIAD
PB Lithuanian Physical Society
DT Journal
LA English
CC 73-2 (Optical, Electron, and Mass Spectroscopy and Other Related
Properties)
Section cross-reference(s): 57
AB Photomodification of optical properties (absorption and **refraction**
) of photo-thereto-**refractive** (PTR) glass by its exposure to
femtosecond (fs) irradiation is reported. Irradiation was made by fs pulses at
the fundamental wavelength of 775 nm and at the 2nd harmonic of 388 nm.
Exposure was controlled by focusing and timing of 1 kHz laser radiation.
Both wavelengths are out of the absorption band of Ce³⁺ centered at 304 nm
with the bandwidth of .apprx.40 nm. Just this absorption band is
responsible for initiation of photomodification, which finally forms a
ceramic material at the exposed regions after thermal treatment, typically
at 520° for 2 h. Fs illumination can be successfully implemented
to record **refractive** index changes comparable to those recorded
by continuous-wave exposures to a 325. nm line of He-Cd laser. After the
thermal development the **refractive** index changes up to 10⁻⁴ were
obtained. The mechanism of fs photomodification is discussed in terms of
white light continuum (supercontinuum (SC)) generation and
multiphoton absorption. The model of a silicate glass coloration
via the two-photon absorption of fs SC is proposed. It is based on the
comparison of coloration of PTR glass with that of alkali- and
boro-silicate glasses under fs pulses.
ST optical property irradiated photo thermo **refractive** glass; white
light continuum glass laser irradiatn
IT Defects in solids
(effect of formation of; optical properties of femtosecond irradiated
photo-thermo-**refractive** glass)
IT Heat treatment
(effect of; optical properties of femtosecond irradiated photo-thermo-
refractive glass)
IT Optical absorption
Optical **refraction**
(induced; optical properties of femtosecond irradiated photo-thermo-
refractive glass)
IT Laser radiation
(irradiation effect; optical properties of femtosecond irradiated
photo-thermo-**refractive** glass)

STN search for 10/622488

- IT Optical properties
Refractive index
Two-photon absorption
UV and visible spectra
(optical properties of femtosecond irradiated photo-thermo-
refractive glass)
- IT Silicate glasses
RL: PRP (Properties)
(optical properties of femtosecond irradiated photo-thermo-
refractive glass)
- IT Glass, properties
RL: PRP (Properties)
(photo-thermo-refractive; optical properties of femtosecond
irradiated photo-thermo-refractive glass)
- IT 7681-49-4, Sodium fluoride, occurrence
RL: OCU (Occurrence, unclassified); OCCU (Occurrence)
(effect of formation of; optical properties of femtosecond irradiated
photo-thermo-refractive glass)
- IT 1305-78-8, Calcium oxide, occurrence 1306-38-3, Cerium dioxide,
occurrence 1313-59-3, Sodium oxide, occurrence 1314-13-2, Zinc oxide,
occurrence 1344-28-1, Aluminum oxide, occurrence 7631-86-9, Silicon
oxide, occurrence 7758-02-3, Potassium bromide, occurrence 20667-12-3,
Silver oxide
RL: OCU (Occurrence, unclassified); OCCU (Occurrence)
(glass containing; optical properties of femtosecond irradiated
photo-thermo-refractive glass)

RE.CNT 33 THERE ARE 33 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE

- (1) Akamatsu, K; J Phys Chem B 2000, V104, P10168 CAPLUS
- (2) Astakhova, V; Sov J Glass Phys Chem 1992, V18(2), P152
- (3) Blakely, J; Surf Sci 1997, V394, P221
- (4) Borgman, V; Izv Akad Nauk SSSR, Neorg Mater 1970, V4(2), P336
- (5) Boulos, E; J Non-Cryst Solids 1997, V221, P213 CAPLUS
- (6) Docenko, A; Sov J Glass Phys Chem 1985, V11, P592
- (7) Doll, K; Phys Rev B 1997, V56(16), P10121 CAPLUS
- (8) Doll, K; Phys Rev B 1998, V57(8), P4327 CAPLUS
- (9) Efimov, O; Appl Opt OT 2002, V41(10), P1864 CAPLUS
- (10) Efimov, O; J Non-Cryst Solids 1999, V253, P58 CAPLUS
- (11) Efimov, O; J Opt Soc Am B 1998, V15(1), P193 CAPLUS
- (12) Efimov, O; Opt Lett 2001, V25(23), P1693
- (13) Francois-Saint-Cyr, H; Ph D thesis, Univ Central Florida 2001
- (14) Francois-Saint-Cyr, H; Unpublished results 2001
- (15) Glebov, L; Glass Science and Technology (Glastechnische Berichte) 1998,
V71C, P85
- (16) Glebov, L; J Non-Cryst Solids 1998, V242, P49 CAPLUS
- (17) Glebov, L; Proc Laser-Induced Damage in Optical Materials:2000 2001,
V4347, P343
- (18) Glebov, L; Sov J Glass Phys Chem 1976, V2, P547
- (19) Glebov, L; Sov J Glass Phys Chem 1987, V3, P310
- (20) Glebov, L; Sov J Glass Phys Chem 1990, V16(1), P39 CAPLUS
- (21) Glebov, L; Sov Phys Dokl 1990, V35(10), P878
- (22) Juodkazis, S; Appl Surf Sci 2000, V154-155, P696 CAPLUS
- (23) Juodkazis, S; Res Adv Appl Phys 2001, V2, P45
- (24) Juodkazis, S; physics/0203080v1 2002 CAPLUS
- (25) Lunter, S; Sov J Appl Spectrosc 1968, V8(6), P964 CAPLUS
- (26) Paje, S; Appl Phys A 1996, V63, P431
- (27) Pansheva, E; Sov J Glass Phys Chem 1993, V19(1), P109 CAPLUS
- (28) Smakula, A; Z Phys 1930, V59, P603 CAPLUS
- (29) Steele, F; Phys Chem Glasses 1965, V6, P246 CAPLUS
- (30) Stookey, S; Industrial Engrg Chem 1949, V41, P856 CAPLUS

STN search for 10/622488

- (31) Trukhin, A; Phys Status Solidi B 1980, V99, P155 CAPLUS
(32) Trukhin, A; Sov J Glass Phys Chem 1979, V5, P634
(33) Watanabe, M; Phys Rev B 1999, V60, P9959 CAPLUS

L4 ANSWER 3 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2002:160423 CAPLUS
DN 136:207766
ED Entered STN: 05 Mar 2002
TI Method and apparatus for laser marking and marked optical materials
IN Hayashi, Kenichi
PA Sumitomo Heavy Industries, Ltd., Japan
SO Jpn. Kokai Tokkyo Koho, 5 pp.
CODEN: JKXXAF
DT Patent
LA Japanese
IC ICM B23K026-00
ICS B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18;
G02B005-32
CC 74-8 (Radiation Chemistry, Photochemistry, and Photographic and Other
Reprographic Processes)
Section cross-reference(s): 73
FAN.CNT 1

	PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
PI	JP 2002066769	A2	20020305	JP 2000-257182	20000828
	JP 3522670	B2	20040426		
PRAI	JP 2000-257182		20000828		

CLASS

PATENT NO.	CLASS	PATENT FAMILY CLASSIFICATION CODES
JP 2002066769	ICM	B23K026-00
	ICS	B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18; G02B005-32

- AB The apparatus comprises a laser beam source, a hologram plate, an optical scanning system for deflection of the diffraction beams, an optical focusing system for convergence of the diffraction beams, and a stage for placing the marking substrate at the positions where the diffraction beams are converged. Marking of materials by forming multiple nos. of points having varied **refractive** index caused by **multiphoton** absorption is claimed. Optical materials marked with patterns that diffract **visible** light and method for marking are also claimed. Easily **visible** markings are formed without damaging the marked materials.
- ST laser marking app optical material; **multiphoton** absorption laser marking; grating laser induced marking holog
- IT Holographic diffraction gratings
Laser induced grating
(apparatus for highly **visible** laser marking of materials without their damaging)
- IT Marking
(laser; apparatus for highly **visible** laser marking of materials without their damaging)
- IT **Multiphoton** absorption
(marking by; apparatus for highly **visible** laser marking of materials without their damaging)
- IT Glass, processes
RL: PEP (Physical, engineering or chemical process); PYP (Physical process); PROC (Process)
(marking of; apparatus for highly **visible** laser marking of materials without their damaging)

STN search for 10/622488

L4 ANSWER 4 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2001:734065 CAPLUS
DN 135:296267
ED Entered STN: 09 Oct 2001
TI Method of making **visible** marks in a transparent material by
laser beam radiation, marking apparatus, and transparent optical member
marked by the method
IN Hayashi, Kenichi; Ito, Kazuyoshi
PA Sumitomo Heavy Industries, Ltd., Japan
SO Jpn. Kokai Tokkyo Koho, 9 pp.
CODEN: JKXXAF
DT Patent
LA Japanese
IC ICM B23K026-00
ICS B23K026-00; B23K026-04; B23K026-08; C03C023-00; G02B005-18
CC 74-13 (Radiation Chemistry, Photochemistry, and Photographic and Other
Reprographic Processes)
Section cross-reference(s): 73

FAN.CNT 1

	PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
PI	JP 2001276985	A2	20011009	JP 2000-258854	20000829
	JP 3522671	B2	20040426		
	US 2002041323	A1	20020411	US 2001-940604	20010829
	US 6621041	B2	20030916		
PRAI	JP 2000-19062	A	20000127		
	JP 2000-258854	A	20000829		

CLASS

PATENT NO.	CLASS	PATENT FAMILY CLASSIFICATION CODES
JP 2001276985	ICM	B23K026-00
	ICS	B23K026-00; B23K026-04; B23K026-08; C03C023-00; G02B005-18
US 2002041323	ECLA	G02B005/18M2

AB In marking a transparent material, a laser beam of wavelength capable of transmitting the material is focused on inner part of the transparent material to allow **multiphoton** absorption and cause n changes, and the focal point of the laser beam is so moved as to form a diffraction pattern which diffracts a **visible** ray. An optically marking apparatus is equipped with a stage for loading the material, a light source emitting the laser beam, an optical system for focusing the laser beam, and a means of moving the focal point to form the diffraction grating. A transparent optical member, marked by the method, has the diffraction pattern inside. Alternatively, a method of marking marks in a material comprises the following steps; (1) irradiating the material with a pulsed laser beam by changing NA of an object lens and energy intensity per one pulse (EI) to form optically modified region, (2) determining a function of NA, EI, and length of modified region (LE), (3) determining NA and EI from the required LE by using the function, and (4) irradiating the laser beam to form the modified region. The marking method does not cause damage or drop in strength of the material, and the formed mark can be easily recognized without using a readout apparatus

ST transparent material marking laser radiation n change; diffraction grating formation laser radiation transparent material marking;
multiphoton absorption laser induced diffraction grating marking;
glass marking laser induced diffraction grating

IT **Refractive** index
(changes; making **visible** marks in transparent material by
laser beam radiation, marking apparatus, and mark-formed transparent optical

STN search for 10/622488

- member)
- IT **Multiphoton** absorption
(laser radiation; making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)
- IT Laser induced grating
Marking
Transparent materials
(making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)
- IT Laser radiation
(pulsed; making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)
- IT Glass substrates
(transparent; making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)
- L4 ANSWER 5 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2001:262366 CAPLUS
DN 135:38692
ED Entered STN: 13 Apr 2001
TI Polydiacetylene PTS: a molecular quantum wire with exceptional optical properties
AU Trevino-Palacios, Carlos G.; Stegeman, George; Liu, Mingguo; Yoshino, Fumiyo; Poliakov, Sergey; Friedrich, Lars; Flom, Steven R.; Lindle, J. R.; Bartoli, F. J.
CS School of Optics and CREOL, University of Central Florida, Orlando, FL, USA
SO NATO Science Series, II: Mathematics, Physics and Chemistry (2000), 6(Frontiers of Nano-Optoelectronic Systems), 209-226
CODEN: NSSICD
PB Kluwer Academic Publishers
DT Journal
LA English
CC 73-10 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
Section cross-reference(s): 36
AB The conjugated polymer 2,4-hexadiyne-1,6-diolbis(p-toluenesulfonate) or PTS is a classical example of a 1-dimensional quantum wire. The π -electrons can move more or less freely in 1 dimension. There are large repercussions to this effect in the photonics field, including photocond., and the linear and nonlinear optical response. Growing techniques of crystals with high optical quality as well as measurements on a variety of nonlinear optical effects of PTS are reported in this chapter. These include measurements on the large magnitude of the exciton absorption line, the well-defined vibrational side bands at room temperature, massive 2 and 4 photon absorption coeffs., very large Raman gain coeffs., minimal excited state absorption and a large nonlinear **refractive** index.
ST polydiacetylene PTS mol quantum wire exceptional optical property
IT Quantum wire devices
(mol.; hexadiynediolbis(toluenesulfonate) with exceptional optical properties)
IT IR spectra
(near-IR, transient; of hexadiynediolbis(toluenesulfonate) mol. quantum wire)
IT **Refractive** index
(nonlinear; of hexadiynediolbis(toluenesulfonate) mol. quantum wire)

STN search for10/622488

IT Absorptivity
Degenerate four wave mixing
Excited state absorption
Exciton
 Multiphoton absorption
Nonlinear optical properties
Optical properties
Photoconductivity
Raman spectra
UV and **visible** spectra
 (of hexadiynediolbis(toluenesulfonate) mol. quantum wire)
IT 32535-60-7, Poly(2,4-Hexadiyne-1,6-diol bis(p-toluenesulfonate))
51853-07-7, Poly(2,4-Hexadiyne-1,6-diol bis(p-toluenesulfonate)), SRU
RL: DEV (Device component use); PRP (Properties); USES (Uses)
 (mol. quantum wire with exceptional optical properties)
RE.CNT 26 THERE ARE 26 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE
(1) Albouy, P; J Am Chem Soc 1982, V104, P6556 CAPLUS
(2) Anon; CRC Handbook of laser science and Technology, Supplement 2: Optical
Materials 1995, P308
(3) Anon; Proceedings of the NATO Advanced Research Workshop in Atomic and
Molecular Wires 1996, V341
(4) Baughman, R; J Polym Sci 1974, V12, P1511 CAPLUS
(5) Bloor, D; J Mat Sci 1975, V10, P1678 CAPLUS
(6) Bloor, D; J Pol Sci B 1977, V15, P703 CAPLUS
(7) Carter, G; App Phys Lett 1985, V47, P457 CAPLUS
(8) Chance, R; J Pol Sci B 1978, V16, P859 CAPLUS
(9) Dudley, M; Mol Cryst Liq Cryst 1983, V93, P223 CAPLUS
(10) Greene, B; Chem Phys Lett 1987, V139, P381 CAPLUS
(11) Ito, T; J Polym Sci 1974, V12, P11 CAPLUS
(12) Jensen, S; IEEE J Quantum Elect 1982, VQE-18, P1580
(13) Krug, W; J Opt Soc Am B 1989, V6, P726 CAPLUS
(14) Lequime, M; Chem Phys 1977, V26, P431 CAPLUS
(15) Mukhopadhyay, D; J Chem Phys 1996, V104, P1600 CAPLUS
(16) Sasaki, K; J Opt Soc Am B 1998, V5, P457
(17) Sasaki, K; Materials Research Society Symposium Proceedings on Electrical
Optical and Magnetic Properties of Organic Solid State Materials 1992,
V247, P141 CAPLUS
(18) Soos, Z; Chem Phys 1996, V210, P249 CAPLUS
(19) Thakur, M; Appl Phys Lett 1999, V74, P635 CAPLUS
(20) Townsend, P; Appl Phys Lett 1989, V55, P1829 CAPLUS
(21) Wegner, G; Makromol Chem 1971, V145, P85 CAPLUS
(22) Wegner, G; Molecular Metals 1979, P209
(23) Wegner, G; Z Naturforsch B 1969, V24, P824 CAPLUS
(24) Winful, H; Appl Phys Lett 1979, V35, P379 CAPLUS
(25) Young, R; J Mat Sci 1981, V16, P1835 CAPLUS
(26) Young, R; J Mat Sci 1982, V20, P961 CAPLUS

L4 ANSWER 6 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2000:482928 CAPLUS
DN 133:244952
ED Entered STN: 18 Jul 2000
TI Wavelength dependence of photoreduction of Ag⁺ ions in glasses through the
multiphoton process
AU Kondo, Yuki; Inouye, Hideyuki; Fujiwara, Seiji; Suzuki, Toshio; Mitsuyu,
Tsuneo; Yoko, Toshinobu; Hirao, Kazuyuki
CS Hirao Active Glass Project, Exploratory Research for Advanced Technolog,
Super-Lab 2F6, Japan Science and Technology Corporation, Seika, Kyoto,
619-0237, Japan
SO Journal of Applied Physics (2000), 88(3), 1244-1250

STN search for 10/622488

CODEN: JAPIAU; ISSN: 0021-8979

PB American Institute of Physics

DT Journal

LA English

CC 74-1 (Radiation Chemistry, Photochemistry, and Photographic and Other Reprographic Processes)

Section cross-reference(s): 57, 73

AB We have investigated the wavelength dependence of the photoreduction of Ag⁺ ions in glass irradiated by visible femtosecond pulses. These pulses, issued at wavelengths ranging from 400 to 800 nm, were nonresonant with the glass absorption. In this article, a relationship between threshold powers, wavelengths, and linear and nonlinear refractive indexes is described. The nonlinear refractive index of Ag⁺-doped glass was measured by an optical Kerr shutter method. The wavelength dependence of threshold powers of the photoreduction is explained by considering linear and nonlinear refractive indexes. The mechanism of the photoreduction is also discussed.

ST photoreduction silver glass nonlinear refraction

IT Aluminosilicate glasses

RL: PEP (Physical, engineering or chemical process); RCT (Reactant); TEM (Technical or engineered material use); PROC (Process); RACT (Reactant or reagent); USES (Uses)

(sodium; wavelength dependence of photoreduction of Ag⁺ ions in glasses through the multiphoton process)

IT Nonlinear optical refraction

Photon

Reduction, photochemical

Refractive index

(wavelength dependence of photoreduction of Ag⁺ ions in glasses through the multiphoton process)

IT 1314-13-2, Zinc oxide, uses 1314-60-9, Antimony pentoxide 7681-49-4, Sodium fluoride, uses 18282-10-5, Tin dioxide

RL: TEM (Technical or engineered material use); USES (Uses)

(glass; wavelength dependence of photoreduction of Ag⁺ ions in glasses through the multiphoton process)

IT 14701-21-4, Silver 1+, reactions

RL: PEP (Physical, engineering or chemical process); RCT (Reactant); TEM (Technical or engineered material use); PROC (Process); RACT (Reactant or reagent); USES (Uses)

(wavelength dependence of photoreduction of Ag⁺ ions in glasses through the multiphoton process)

RE.CNT 29 THERE ARE 29 CITED REFERENCES AVAILABLE FOR THIS RECORD

RE

- (1) Alfano, R; Phys Rev Lett 1970, V24, P592 CAPLUS
- (2) Ashkenasi, D; Appl Phys Lett 1998, V72, P1442 CAPLUS
- (3) Bloembergen, N; IEEE J Quantum Electron 1974, VQE-10, P375
- (4) Bloembergen, N; Opt Commun 1973, V8, P285
- (5) Braun, A; Opt Lett 1995, V20, P73
- (6) Brodeur, A; Opt Commun 1996, V129, P193 CAPLUS
- (7) Cho, S; Jpn J Appl Phys Part 2 1998, V37, PL737 CAPLUS
- (8) Close, D; IEEE J Quantum Electron 1966, VQE-2, P553
- (9) Davis, K; Opt Lett 1996, V21, P1729 CAPLUS
- (10) Efimov, O; J Opt Soc Am B 1998, V15, P193 CAPLUS
- (11) Glebov, L; Proceedings of 18th Int Congress on Glass 1998, P17
- (12) Glezer, E; Appl Phys Lett 1997, V71, P882 CAPLUS
- (13) Golub, I; Opt Lett 1990, V15, P305 CAPLUS
- (14) Kanbara, H; Opt Commun 1998, V148, P101 CAPLUS
- (15) Kobayashi, H; J Appl Phys 1993, V74, P3683 CAPLUS
- (16) Kondo, Y; J Non-Cryst Solids 1999, V253, P143 CAPLUS
- (17) Kondo, Y; Jpn J Appl Phys Part 2 1998, V37, PL94 CAPLUS

STN search for10/622488

- (18) Kondo, Y; Jpn J Appl Phys Part 2 1999, V38, PL1146 CAPLUS
- (19) Kondo, Y; Opt Lett 1999, V24, P646 CAPLUS
- (20) Kondo, Y; Proceedings of 18th Int Congress on Glass 1998, P36
- (21) Kosareva, O; Opt Lett 1997, V22, P1332 CAPLUS
- (22) Marburger, J; Progress in Quantum Electron 1975, V4, P35
- (23) Monot, P; J Opt Soc Am B 1992, V9, P1579 CAPLUS
- (24) Owyong, A; IEEE J Quantum Electron 1973, V9, P1064 CAPLUS
- (25) Qiu, J; Jpn J Appl Phys Part 1 1998, V37, P2263 CAPLUS
- (26) Sigel, G; J Phys Chem Solids 1971, V32, P2373 CAPLUS
- (27) Stookey, S; Ind Eng Chem 1949, V41, P856 CAPLUS
- (28) Taylor, A; Opt Lett 1996, V21, P1812 CAPLUS
- (29) Xing, Q; Appl Opt 1993, V32, P2087 CAPLUS

L4 ANSWER 7 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1999:535149 CAPLUS
DN 131:264484
ED Entered STN: 26 Aug 1999
TI Enhanced photosensitivity in germanosilicate fibers exposed to CO2 laser radiation
AU Brambilla, G.; Pruneri, V.; Reekie, L.; Payne, D. N.
CS Optoelectronics Research Centre, Southampton University, Southampton, SO17-1BJ, UK
SO Optics Letters (1999), 24(15), 1023-1025
CODEN: OPLEDP; ISSN: 0146-9592
PB Optical Society of America
DT Journal
LA English
CC 73-11 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
Section cross-reference(s): 57, 74
AB The authors report a novel method to increase the UV photosensitivity of GeO2:SiO2 optical fibers based on exposure to CO2 laser irradiation before grating writing. Fibers treated with a CO2 laser can produce gratings with refractive-index modulation 2 times greater and a Bragg wavelength that can be 2 nm longer than those of untreated fibers. Expts. on GeO2:SiO2 preform samples treated with a CO2 laser in a way similar to the fibers showed a marked increase of the 242-nm absorption band, which is associated with an increase of Ge O-deficient centers and is believed to be responsible for the higher photorefractive response.
ST photosensitivity germanosilicate optical fiber carbon dioxide laser radiation; diffraction grating germanosilicate optical fiber photosensitivity laser irradiation; multiphoton absorption germanosilicate optical fiber photosensitivity laser irradiation; photorefractive germanosilicate optical fiber photosensitivity laser irradiation; near IR reflection germanosilicate optical fiber diffraction grating photosensitivity; UV optical fiber preform photosensitivity laser irradiation
IT Diffraction gratings
Laser radiation
Multiphoton absorption
Optical fibers
Photorefractive effect
UV and visible spectra
(enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with diffraction gratings)
IT IR reflectance spectra
(near-IR; enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with diffraction gratings)
IT Germanosilicate glasses
RL: DEV (Device component use); PEP (Physical, engineering or chemical

STN search for 10/622488

process); PRP (Properties); PROC (Process); USES (Uses)
(optical fibers; enhanced photosensitivity in germanosilicate optical
fibers exposed to CO2 laser radiation with diffraction gratings)

IT Glass fibers, properties
RL: DEV (Device component use); PEP (Physical, engineering or chemical
process); PRP (Properties); PROC (Process); USES (Uses)
(optical germanosilicate; enhanced photosensitivity in germanosilicate
optical fibers exposed to CO2 laser radiation with diffraction
gratings)

IT Defects in solids
(oxygen-deficient; enhanced photosensitivity in germanosilicate optical
fibers exposed to CO2 laser radiation with diffraction gratings)

IT 1310-53-8, Germania, properties 60676-86-0, Vitreous silica
RL: DEV (Device component use); PEP (Physical, engineering or chemical
process); PRP (Properties); PROC (Process); USES (Uses)
(enhanced photosensitivity in germanosilicate optical fibers exposed to
CO2 laser radiation with diffraction gratings)

RE.CNT 12 THERE ARE 12 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE

(1) Bilodeau, F; Opt Lett 1993, V18, P953 CAPLUS
(2) Byron, K; US 5694502 1997
(3) Dong, L; IEEE Photon Technol Lett 1995, V7, P1048
(4) Douay, M; Ann Telecommun 1997, V52, P543
(5) Hill, K; Appl Phys Lett 1978, V32, P647
(6) Hill, K; Optical Fiber Communication 1991, V1, P14
(7) Hosono, H; Phys Rev B 1992, V46, P11445 CAPLUS
(8) Lee, J; J Non-Cryst Solids 1998, V239, P57 CAPLUS
(9) Lemaire, P; Electron Lett 1993, V29, P1191 CAPLUS
(10) Othonos, A; Rev Sci Instrum 1997, V68, P4309 CAPLUS
(11) Takahashi, M; Appl Phys Lett 1998, V72, P1287 CAPLUS
(12) Williams, D; Electron Lett 1993, V29, P45

L4 ANSWER 8 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1998:54471 CAPLUS
DN 128:198067
ED Entered STN: 30 Jan 1998
TI Linear optical properties and **multiphoton** absorption of alkali
halides calculated from first principles
AU Li, Jun; Duan, Chun-gang; Gu, Zong-quan; Wang, Ding-sheng
CS Center for Condensed Matter Physics, Institute of Physics, Laboratory for
Surface Physics, Academia Sinica, Beijing, 100080, Peop. Rep. China
SO Physical Review B: Condensed Matter and Materials Physics (1998), 57(4),
2222-2228
CODEN: PRBMDO; ISSN: 0163-1829
PB American Physical Society
DT Journal
LA English
CC 73-4 (Optical, Electron, and Mass Spectroscopy and Other Related
Properties)
Section cross-reference(s): 76

AB This paper reports the calcn. of linear optical properties and
multiphoton absorption (MPA) coeffs. of alkali halides MX (M = Na,
K; X = F, Cl, Br, I) using the 1st-principles linearized APW band method
and the time-dependent perturbation theory. The calcns. are in good
agreement with available exptl. data. For linear optical properties, the
trend of the static dielec. consts. with respect to the halides is
attributed to the variation of the optical oscillator strength arising
from the electronic transitions of the valence p bands. For MPA coeffs.
the spectra of 2-photon absorption given in the region of photon energy
(1/2Eg, Eg) show an increase of MPA coeffs. with respect to the atomic number
of

STN search for 10/622488

the halogen elements. The polarization dependence of the MPA coeffs. is also given, which promotes further expts.

ST alkali halide optical property **multiphoton** absorption; sodium halide optical property **multiphoton** absorption; potassium halide optical property **multiphoton** absorption; **refractive** index alkali halide; oscillator strength alkali halide; dielec const alkali halide; band structure alkali halide; two photon absorption alkali halide; UV **visible** alkali halide two photon

IT Band structure
Dielectric constant
Multiphoton absorption
Oscillator strength
Refractive index
Two-photon absorption
(linear optical properties and **multiphoton** absorption of alkali halides calculated from first principles)

IT Alkali metal halides, properties
RL: PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process)
(linear optical properties and **multiphoton** absorption of alkali halides calculated from first principles)

IT UV and **visible** spectra
(two-photon; linear optical properties and **multiphoton** absorption of alkali halides calculated from first principles)

IT 7447-40-7, Potassium chloride (KCl), properties 7647-14-5, Sodium chloride (NaCl), properties 7647-15-6, Sodium bromide (NaBr), properties 7681-11-0, Potassium iodide (KI), properties 7681-49-4, Sodium fluoride (NaF), properties 7681-82-5, Sodium iodide (NaI), properties 7758-02-3, Potassium bromide (KBr), properties 7789-23-3, Potassium fluoride (KF)
RL: PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process)
(linear optical properties and **multiphoton** absorption of alkali halides calculated from first principles)

RE.CNT 31 THERE ARE 31 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE

(1) Adair, R; Phys Rev B 1989, V39, P3337 CAPLUS
(2) Bethe, H; Quantum Mechanics of One- and Two-electron Atoms, Secs 61 and 62 1957
(3) Braunstein, R; Phys Rev 1962, V125, P475 CAPLUS
(4) Brost, G; Phys Rev B 1984, V30, P4675 CAPLUS
(5) Brown, F; Phys Rev B 1970, V2, P2126
(6) Catalano, I; Opt Commun 1972, V5, P212 CAPLUS
(7) Catalano, I; Phys Rev B 1972, V5, P1629
(8) Ching, W; Phys Rev B 1993, V47, P9479 CAPLUS
(9) Ching, W; Phys Rev B 1995, V52, P1596 CAPLUS
(10) Chuangtian, C; Laser Focus World 1989, VXX, P129
(11) Hohenberg, P; Phys Rev 1964, V136, PB864
(12) Huang, M; Phys Rev B 1993, V47, P9449 CAPLUS
(13) Huang, M; Phys Rev B 1993, V47, P9464 CAPLUS
(14) Hybertsen, M; Phys Rev B 1986, V34, P5390 CAPLUS
(15) Jones, S; Opt Eng (Bellingham) 1989, V28, P1039 CAPLUS
(16) Jones, S; Phys Rev B 1988, V37, P755 CAPLUS
(17) Koelling, D; J Phys C 1977, V10, P3107 CAPLUS
(18) Koelling, D; J Phys F 1975, V5, P2041 CAPLUS
(19) Kohn, W; Phys Rev 1965, V140, PA1133
(20) Krakauer, H; Phys Rev B 1979, V19, P1706 CAPLUS
(21) Kunz, A; Phys Rev B 1982, V26, P2056 CAPLUS
(22) Li, J; Ph D dissertation, Academia Sinica 1997
(23) Lines, M; Phys Rev B 1990, V41, P3383

STN search for 10/622488

- (24) Liu, P; Phys Rev B 1978, V17, P4620 CAPLUS
- (25) Nathan, V; J Opt Soc Am B 1985, V2, P294 CAPLUS
- (26) Palik, E; Handbook of Optical Constants of Solids 1985, P703
- (27) Shen, X; Phys Rev B 1987, V36, P2831 CAPLUS
- (28) Smith, D; Handbook of Optical Constants of Solids, Chap 3 1985, P703
- (29) Tropic, W; Handbook of Optics, 2nd ed, Chap 33 1995, V2
- (30) Wang, C; Phys Rev B 1981, V24, P3417 CAPLUS
- (31) Zhang, W; Opt Commun 1996, V126, P61 CAPLUS

L4 ANSWER 9 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1996:708975 CAPLUS
DN 126:39300
ED Entered STN: 29 Nov 1996
TI Writing waveguides in glass with a femtosecond laser
AU Davis, K. M.; Miura, K.; Sugimoto, N.; Hirao, K.
CS Exploratory Research Advanced Technology, Research Development Corporation
Japan, Kyoto, G06, Japan
SO Optics Letters (1996), 21(21), 1729-1731
CODEN: OPLEDP; ISSN: 0146-9592
PB Optical Society of America
DT Journal
LA English
CC 73-11 (Optical, Electron, and Mass Spectroscopy and Other Related
Properties)
AB With the goal of being able to create optical devices for the
telecommunications industry, the effects of 810-nm, fs laser radiation on
various glasses were studied. By focusing the laser beam through a
microscope objective, the transparent, but **visible**,
round-elliptical damage lines were written inside high-SiO₂, borate, soda
lime silicate, and fluorozirconate (ZBLAN) bulk glasses..
Microellipsometer measurements of the damaged region in the pure and
Ge-doped SiO₂ glasses showed a 0.01-0.035 **refractive index**
increase, depending on the radiation dose. The formation of several
defects, including Si E' or Ge E' centers, nonbridging O hole centers, and
peroxy radicals, was detected. Probably **multiphoton**
interactions occur in the glasses, and it may be possible to write
3-dimensional optical circuits in bulk glasses with such a focused laser
beam technique.
ST waveguide glass writing femtosecond laser
IT Glass, properties
RL: PRP (Properties)
(fluorozirconate; writing waveguides with fs laser in)
IT Lenses
(microscope; writing waveguides in glass with fs laser using)
IT Peroxides, formation (nonpreparative)
RL: FMU (Formation, unclassified); FORM (Formation, nonpreparative)
(radicals; in waveguides written in glass with fs laser)
IT Glass, properties
RL: PRP (Properties)
(silica; writing waveguides with fs laser in)
IT Communication
(telecommunication; writing waveguides in glass with fs laser for)
IT Waveguides
(writing in glass with fs laser)
IT Laser radiation
(writing waveguides in glass with fs)
IT Optical instruments
(writing waveguides in glass with fs laser for)
IT Borate glasses
Soda-lime glasses

STN search for 10/622488

RL: PRP (Properties)
(writing waveguides with fs laser in)

IT 7440-56-4, Germanium, uses
RL: MOA (Modifier or additive use); USES (Uses)
(writing waveguides with fs laser in silica glass doped with)

L4 ANSWER 10 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1993:112173 CAPLUS
DN 118:112173
ED Entered STN: 19 Mar 1993
TI The lowest excited singlet state of 1,4-diphenyl-1,3-cyclopentadiene
AU Ci, Xiaopei; Kohler, Bryan E.; Moller, Soren; Shaler, Thomas A.; Yee, W.
Atom
CS Dep. Chem., Univ. California, Riverside, CA, 92521-0403, USA
SO Journal of Physical Chemistry (1993), 97(8), 1515-20
CODEN: JPCHAX; ISSN: 0022-3654
DT Journal
LA English
CC 73-4 (Optical, Electron, and Mass Spectroscopy and Other Related
Properties)

AB The authors report a high-resolution excitation spectrum for
1,4-diphenyl-1,3-cyclopentadiene cooled in a supersonic expansion. The
spectrum, which was obtained using 2-color resonance-enhanced
multiphoton ionization techniques, has an origin at 27,008 cm⁻¹.
The dependence of absorption and fluorescence spectra on solvent and the
vapor phase absorption spectrum shows that the lowest energy excited
singlet state in the isolated mol. is the 2A state. The order of excited
singlet states reverses in the condensed phase: the 1B state is S1 in
solvents with **refractive** indexes of 1.25-1.56. The lifetime of
the 2A state in the isolated mol. could not be accurately determined, though an
upper bound of 10 ns could be placed on it. These results give insight
into the effect that an s-cis conformation in a polyene has on its
electronic structure.

ST singlet state lowest excited diphenylcyclopentadiene;
phenylcyclopentadiene spectra lowest excited singlet state;
cyclopentadiene diphenyl spectra lowest excited singlet; electronic
spectra diphenylcyclopentadiene; **multiphoton** ionization spectra
diphenylcyclopentadiene; vibrational spectra diphenylcyclopentadiene

IT Fluorescence
Infrared spectra
Molecular vibration
Ultraviolet and **visible** spectra
(of diphenylcyclopentadiene)

IT Electronic structure
(of diphenylcyclopentadiene, conformation effects on)

IT Conformation and Conformers
(of diphenylcyclopentadiene, electronic structure dependence on)

IT Solvent effect
(on electronic spectra of diphenylcyclopentadiene, by organic solvents)

IT Energy level transition
(electronic, radiative, of diphenylcyclopentadiene, fluorescence
lifetimes in relation to)

IT Ionization, photo-
(resonant **multiphoton**, two-color, of diphenylcyclopentadiene)

IT Energy level
(singlet, lowest, of diphenylcyclopentadiene)

IT 4982-34-7, 1,4-Diphenyl-1,3-cyclopentadiene
RL: PRP (Properties)
(singlet lowest excited state and electronic and vibrational spectra
of, conformation in relation to)

STN search for 10/622488

L4 ANSWER 11 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1991:617994 CAPLUS
DN 115:217994
ED Entered STN: 15 Nov 1991
TI **Refraction** of molecular gases in the IR laser field
AU Burtsev, A. P.; Korotkov, S. A.; Popov, A. G.; Tret'yakov, P. Yu.;
Khikmatov, H. G.
CS USSR
SO Molekulyarnaya Spektroskopiya (1990), 8, 61-76
CODEN: MLKSA9
DT Journal
LA Russian
CC 73-10 (Optical, Electron, and Mass Spectroscopy and Other Related
Properties)
AB Mach-Zehnder interferometric study of the kinetics of **refractive**
index variation Δn during a **multiphoton** absorption of a
pulsed IR radiation showed the effect of vibrational excitation on the average
mol. polarizability of gaseous SF₆, CF₃I, (CF₃)₃CI, OsO₄, and CF₂Cl₂. In
the **visible** spectral region, the initial sharp increase in
 Δn was followed by an oscillatory decay due to a superposition of
the vibrational-translational relaxation and an acoustic-wave-induced d.
wave in the gas.
ST polarizability mol IR pulse excitation gas; **refractive** index gas
IR pulse excitation; sulfur fluoride polarizability IR pulse excitation;
fluoromethyl iodide polarizability IR pulse excitation; methyl fluoro
iodide polarizability IR excitation; butyl fluoro iodide polarizability IR
excitation
IT Laser radiation, chemical and physical effects
(heating of mol. gases by pulsed, **refractive** index variation
kinetics in relation to)
IT **Refractive** index and Optical **refraction**
(kinetics of variation of, of mol. gases under pulsed IR laser heating)
IT Polarizability
(of mol. gases under pulsed IR heating)
IT Energy level excitation
(vibrational, of pulsed, of mol. gases, mol. polarizability in relation
to)
IT 75-71-8, Dichlorodifluoromethane 2314-97-8, Trifluoriodomethane
2551-62-4, Sulfur hexafluoride 4459-18-1, Tristrifluoromethyliodomethane
20816-12-0
RL: PRP (Properties)
(**refractive** index variation kinetics of gases, under pulsed
IR laser heating)

=> s (multiphoton or multiple photon) and refract?
13402 MULTIPHOTON
335822 MULTIPLE
116796 PHOTON
955 MULTIPLE PHOTON
(MULTIPLE(W) PHOTON)
208965 REFRACT?
L5 109 (MULTIPHOTON OR MULTIPLE PHOTON) AND REFRACT?

=> s (multiphoton or multiple photon) and diffract?
13402 MULTIPHOTON
335822 MULTIPLE
116796 PHOTON
955 MULTIPLE PHOTON

STN search for 10/622488

(MULTIPLE(W) PHOTON)

418560 DIFFRACT?

L6 106 (MULTIPHOTON OR MULTIPLE PHOTON) AND DIFFRACT?

=> s 15 and 16

L7 9 L5 AND L6

=> d all 1-9

L7 ANSWER 1 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2003:741193 CAPLUS
DN 139:388367
ED Entered STN: 22 Sep 2003
TI Holographic volume gratings in bulk Perylene orange-doped hybrid
inorganic-organic materials by the coherent field of a femtosecond laser
AU Qian, Guodong; Guo, Jiayu; Wang, Minquan; Si, Jinhai; Qiu, Jianrong;
Hirao, Kazuyuki
CS State Key Lab of Silicon Materials, Department of Materials Science and
Engineering, Zhejiang University, Hangzhou, 310035, Peop. Rep. China
SO Applied Physics Letters (2003), 83(12), 2327-2329
CODEN: APPLAB; ISSN: 0003-6951
PB American Institute of Physics
DT Journal
LA English
CC 74-8 (Radiation Chemistry, Photochemistry, and Photographic and Other
Reprographic Processes)
Section cross-reference(s): 73
AB Holog. volume gratings with high first-order Bragg **diffraction**
efficiency (greater than 35%) were fabricated in bulk laser-dye-doped
hybrid inorg.-organic materials by the coherent fields of a femtosecond
laser. Observations of optical microscopy show that **refractive**
-index-modulated volume gratings were realized inside the sample through
multiphoton absorption process. The isomerization and alignment
of the laser dye mols. are responsible for the grating formation. The
authors suggest that the materials co-doped with laser dye and azo-dye and
with photoinduced gratings inside are promising materials for making the
distributed feedback tunable lasers.
ST holog grating Perylene orange doped hybrid inorg org material
IT Lasers
(distributed feedback, tunable; holog. volume gratings fabricated in bulk
of sol-gel derived hybrid inorg.-organic materials doped with laser dye in
relation to)
IT Holographic **diffraction** gratings
Hybrid organic-inorganic materials
Multiphoton absorption
(holog. volume gratings fabricated in bulk of sol-gel derived hybrid
inorg.-organic materials doped with laser dye)
IT Holography
(holog. volume gratings fabricated in bulk of sol-gel derived hybrid
inorg.-organic materials doped with laser dye in relation to)
IT Molecular orientation
(photoinduced; holog. volume gratings fabricated in bulk of sol-gel
derived hybrid inorg.-organic materials doped with laser dye)
IT Isomerization
(photoisomerization; holog. volume gratings fabricated in bulk of sol-gel
derived hybrid inorg.-organic materials doped with laser dye)
IT 159777-98-7, Perylene orange
RL: MOA (Modifier or additive use); PEP (Physical, engineering or chemical
process); PYP (Physical process); PROC (Process); USES (Uses)
(holog. volume gratings fabricated in bulk of sol-gel derived hybrid

STN search for10/622488

inorg.-organic materials doped with laser dye)
IT 78-08-0, Vinyltriethoxysilane
RL: RCT (Reactant); RACT (Reactant or reagent)
(precursor; preparation of sol-gel derived hybrid inorg.-organic materials)
RE.CNT 21 THERE ARE 21 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE
(1) Canva, M; Opt Lett 1992, V17, P218 CAPLUS
(2) Jiang, X; Appl Phys Lett 1998, V72, P2502 CAPLUS
(3) Kawamura, K; Jpn J Appl Phys, Part 2 2000, V39, PL767 CAPLUS
(4) Kawata, S; Chem Rev (Washington, DC) 2000, V100, P1777 CAPLUS
(5) Kim, D; Appl Phys Lett 1995, V66, P1166 CAPLUS
(6) Labarthe, F; J Phys Chem B 1998, V102, P2654 CAPLUS
(7) Marino, I; Opt Mater (Amsterdam, Neth) 2001, V15, P279 CAPLUS
(8) Nahata, A; IEEE Photonics Technol Lett 2000, V12, P1525
(9) Natansohn, A; Adv Mater (Weinheim, Ger) 1999, V11, P1387 CAPLUS
(10) Olson, C; Nat Mater 2002, V1, P225 CAPLUS
(11) Qian, G; Chem Phys Lett 2003, V368, P555 CAPLUS
(12) Qian, G; J Appl Phys 2000, V88, P2503 CAPLUS
(13) Rocha, L; J Appl Phys 2001, V89, P3067 CAPLUS
(14) Rochon, E; Appl Phys Lett 1995, V66, P136
(15) Schaffer, C; Opt Lett 2001, V26, P93
(16) Shank, C; Appl Phys Lett 1971, V18, P395 CAPLUS
(17) Si, J; Appl Phys Lett 2002, V80, P359 CAPLUS
(18) Xiong, G; Mater Lett 1999, V39, P103 CAPLUS
(19) Yang, Y; Opt Commun 2002, V204, P277 CAPLUS
(20) Zhai, J; J Phys D 2001, V34, P3466 CAPLUS
(21) Zhang, W; Opt Lett 2002, V27, P1105 CAPLUS

L7 ANSWER 2 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2003:92005 CAPLUS
DN 138:346381
ED Entered STN: 06 Feb 2003
TI Photofabrication of periodic microstructures in azo dye-doped polymers by
interference of laser beams
AU Si, J. H.; Qiu, J. R.; Hirao, K.
CS Photon Craft Project, JST, ICORP, 1-7 Hikaridai, Seika-cho, Kyoto,
619-0237, Japan
SO Applied Physics B: Lasers and Optics (2002), 75(8), 847-851
CODEN: APBOEM; ISSN: 0946-2171
PB Springer-Verlag
DT Journal
LA English
CC 74-8 (Radiation Chemistry, Photochemistry, and Photographic and Other
Reprographic Processes)
AB Volume holog. gratings and two-dimensional periodic microstructures in azo
dye-doped poly(Me methacrylate) were fabricated, resp., by interference of
two coherent beams of a femtosecond laser and by interference of three
coherent beams of a nanosecond laser. The dependence of the first-order
Bragg diffraction efficiency and the photoinduced
refractive-index modulation of the gratings on the intensity of
the writing light was investigated. The measurements of the absorption
spectra before and after irradiation with the writing light suggest that the
photoinduced gratings were refractive-index-modulated gratings,
which arose from a photoinduced decomposition reaction of the azo dye mols.
through multiphoton absorption. In the expts. involving the
interference of three beams, the period of the two-dimensional periodic
microstructures was changed by adjusting the angle between the three
writing beams.
ST photofabrication periodic microstructure azo dye doped polymer; vol holog
grating recording azo dye doped PMMA

STN search for 10/622488

IT Laser ablation
Microstructure
(fabrication of two-dimensional periodic microstructures in azo dye-doped PMMA by interference of three coherent beams of nanosecond laser beams)

IT Holographic **diffraction** gratings
Holography
Multiphoton absorption
(fabrication of volume holog. gratings in azo dye-doped PMMA by interference of femtosecond laser beams via **multiphoton**-induced photodecompn. of dopant dye)

IT Photolysis
(**multiphoton**; fabrication of volume holog. gratings in azo dye-doped PMMA by interference of femtosecond laser beams via **multiphoton**-induced photodecompn. of dopant dye)

IT 9011-14-7, PMMA
RL: PEP (Physical, engineering or chemical process); PYP (Physical process); PROC (Process)
(fabrication of volume holog. gratings and two-dimensional periodic microstructures in azo dye-doped PMMA)

IT 144748-38-9
RL: RCT (Reactant); RACT (Reactant or reagent)
(fabrication of volume holog. gratings in azo dye-doped PMMA by interference of femtosecond laser beams via **multiphoton**-induced photodecompn. of dopant dye)

RE.CNT 19 THERE ARE 19 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE

(1) Brott, L; Nature (London) 2001, V413, P291 MEDLINE
(2) Campbell, M; Nature (London) 2000, V404, P53 CAPLUS
(3) Cheben, P; Appl Phys Lett 2001, V78, P1490 CAPLUS
(4) Coufal, H; Nature (London) 1998, V393, P628 CAPLUS
(5) Glezer, E; Appl Phys Lett 1997, V71, P882 CAPLUS
(6) Heanue, J; Science 1994, V265, P749
(7) Hill, K; Opt Lett 1995, V20, P1201
(8) Kawamura, K; Jpn J Appl Phys Part 2 2000, V39, PL767 CAPLUS
(9) Kim, D; Appl Phys Lett 1995, V66, P1166 CAPLUS
(10) Kogelnik, H; Bell System Tech J 1969, V48, P2902
(11) Miura, K; Appl Phys Lett 1997, V71, P3329 CAPLUS
(12) Nakanishi, M; Appl Opt 1998, V37, P1068 CAPLUS
(13) Rochon, P; Appl Phys Lett 1995, V66, P136 CAPLUS
(14) Shen, Y; Makromol Chem 1991, V192, P945 CAPLUS
(15) Shoji, S; Appl Phys Lett 2000, V76, P2668 CAPLUS
(16) Si, J; Appl Phys Lett 2002, V80, P359 CAPLUS
(17) Si, J; J Appl Phys 2001, V89, P2029 CAPLUS
(18) Si, J; Opt Lett 1999, V24, P911 CAPLUS
(19) Watanabe, M; Jpn J Appl Phys Part 2 1998, V37, PL1527

L7 ANSWER 3 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2002:438354 CAPLUS
DN 137:176350
ED Entered STN: 11 Jun 2002
TI In situ observation of dynamics of plasma formation and **refractive** index modification in silica glasses excited by a femtosecond laser
AU Cho, Sung-Hak; Kumagai, Hiroshi; Midorikawa, Katsumi
CS Laser Technology Laboratory, The Institute of Physical and Chemical Research (RIKEN), Wako, Saitama, 351-0198, Japan
SO Optics Communications (2002), 207(1-6), 243-253
CODEN: OPCOB8; ISSN: 0030-4018
PB Elsevier Science B.V.
DT Journal

STN search for 10/622488

LA English
CC 73-2 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
Section cross-reference(s): 57, 76, 77
AB Time-resolved dynamics of plasma formation and bulk **refractive** index modification in SiO₂ glasses excited by a tightly focused femtosecond (110 fs) Ti:sapphire laser ($\lambda_p=800$ nm) was 1st observed in situ. The newly proposed pump-probe measurement with perpendicularly linear polarized beams was used to study the dynamic of both plasma formation and induced **refractive** index bulk modification. The energy variation of transmitted probe beam with time delay, which propagates through the induced plasma is measured. At the pre-breakdown domain, the lifetime of induced plasma formation is .apprx.15 ps and structural transition time for forming the **refractive** index change is .apprx.10 ps. At the breakdown domain, however, the lifetime of induced plasma formation is .apprx.35 ps and structural transition time for forming the optical damage is .apprx.35 ps. The process of **refractive** index bulk modification is significantly different from that of optical damage. According to the ESR spectroscopic measurement, the defect concentration of SiE' center increased significantly in the modified region in related to that of the region without modification. From the diffraction efficiency of Kogelnik's coupled mode theory, the maximum value of **refractive** index change (Δn) is 1.1×10^{-2} . By the scanning of SiO₂ glass on the optical X-Y-Z stages, the fabrication of the internal grating with **refractive** index modification was demonstrated in SiO₂ glass using tightly focused femtosecond laser. The exptl. results will be helpful to understand the phys. mechanism of the plasma and structural transformation induced by tightly focused high-intensity femtosecond lasers in transparent materials.
ST silica glass laser plasma dynamics **refractive** index ESR
photorefraction; self focusing silica glass laser irradiation; multiphoton ionization silica glass laser irradiation; paramagnetic defect silica glass laser irradiation ESR; **diffraction** optical silica glass laser irradiation photorefraction
IT Defects in solids
ESR (electron spin resonance)
Laser induced plasma
Optical damage threshold
Optical **diffraction**
Paramagnetic centers
Photorefractive effect
Refractive index
Structural phase transition
(in situ observation of dynamics of plasma formation and **refractive** index modification in silica glasses excited by femtosecond laser)
IT Photoionization
(**multiphoton**; in situ observation of dynamics of plasma formation and **refractive** index modification in silica glasses excited by femtosecond laser)
IT Optical properties
(self-focusing; in situ observation of dynamics of plasma formation and **refractive** index modification in silica glasses excited by femtosecond laser)
IT 60676-86-0, Vitreous silica
RL: PRP (Properties)
(in situ observation of dynamics of plasma formation and **refractive** index modification in silica glasses excited by femtosecond laser)
RE.CNT 29 THERE ARE 29 CITED REFERENCES AVAILABLE FOR THIS RECORD

STN search for10/622488

RE

- (1) Agrawal, G; Nonlinear Fiber Optics - 2nd 1995
- (2) Ashkenasi, D; Appl Phys Lett 1998, V72, P1442 CAPLUS
- (3) Bennett, H; Proc SPIE 1994, V2428, P469
- (4) Bloembergen, N; IEEE J Quantum Electron 1974, VQE-10, P375
- (5) Bloembergen, N; Opt Commun 1973, V8, P285
- (6) Chen, Y; The Principles of Nonlinear Optics 1984, P303
- (7) Cho, S; Jpn J Appl Phys 1998, V37, PL737 CAPLUS
- (8) Cho, S; Opt Commun 1999, V168, P287 CAPLUS
- (9) Cho, S; SPIE 1998, V3343, P515
- (10) Cho, S; Technical Report of IEICE 1999, VLQE 99-16, P53
- (11) Davis, K; Opt Lett 1996, V21, P1729 CAPLUS
- (12) Du, D; Appl Phys Lett 1994, V64, P3071
- (13) Efimov, O; J Opt Soc Am B 1998, V15, P193 CAPLUS
- (14) Glezer, E; Opt Lett 1996, V21, P2023 CAPLUS
- (15) Griscom, D; J Non-Cryst Solids 1985, V73, P51 CAPLUS
- (16) Hirao, K; Jpn J Non-Cryst Solids 1998, V239, P91 CAPLUS
- (17) Homoelle, D; Opt Lett 1999, V24, P1311 CAPLUS
- (18) Indik, R; Opt Lett 1995, V20, P2315
- (19) Kogelnik, H; Bell Syst Tech J 1969, V48, P2909
- (20) Kondo, Y; Jpn J Appl Phys 1998, V37, PL94 CAPLUS
- (21) Linde, D; J Opt Soc Am B 1996, V13, P216
- (22) Liu, X; Laser Focus World 1997, V33, P101 CAPLUS
- (23) Mittleman, D; J Opt Soc Am B 1996, V13, P170 CAPLUS
- (24) Miura, K; Appl Phys Lett 1997, V71, P3329 CAPLUS
- (25) Newman, B; Proc SPIE 1994, V2428
- (26) Nishii, J; Nucl Instr and Meth B 1998, V141, P625 CAPLUS
- (27) Sulimov, V; Phys Stat Sol A 1996, V158, P155 CAPLUS
- (28) Sun, H; Opt Rev 1996, V6, P396
- (29) Toma, T; Opt Rev 2000, V7, P14 CAPLUS

L7 ANSWER 4 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN

AN 2002:160423 CAPLUS

DN 136:207766

ED Entered STN: 05 Mar 2002

TI Method and apparatus for laser marking and marked optical materials

IN Hayashi, Kenichi

PA Sumitomo Heavy Industries, Ltd., Japan

SO Jpn. Kokai Tokkyo Koho, 5 pp.

CODEN: JKXXAF

DT Patent

LA Japanese

IC ICM B23K026-00

ICS B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18;
G02B005-32

CC 74-8 (Radiation Chemistry, Photochemistry, and Photographic and Other
Reprographic Processes)

Section cross-reference(s): 73

FAN.CNT 1

	PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
PI	JP 2002066769	A2	20020305	JP 2000-257182	20000828
	JP 3522670	B2	20040426		
PRAI	JP 2000-257182		20000828		

CLASS

PATENT NO.	CLASS	PATENT FAMILY CLASSIFICATION CODES
JP'2002066769	ICM	B23K026-00
	ICS	B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18; G02B005-32

STN search for 10/622488

- AB The apparatus comprises a laser beam source, a hologram plate, an optical scanning system for deflection of the **diffraction** beams, an optical focusing system for convergence of the **diffraction** beams, and a stage for placing the marking substrate at the positions where the **diffraction** beams are converged. Marking of materials by forming multiple nos. of points having varied **refractive** index caused by **multiphoton** absorption is claimed. Optical materials marked with patterns that **diffract** visible light and method for marking are also claimed. Easily visible markings are formed without damaging the marked materials.
- ST laser marking app optical material; **multiphoton** absorption laser marking; grating laser induced marking holog
- IT Holographic **diffraction** gratings
Laser induced grating
(apparatus for highly visible laser marking of materials without their damaging)
- IT Marking
(laser; apparatus for highly visible laser marking of materials without their damaging)
- IT **Multiphoton** absorption
(marking by; apparatus for highly visible laser marking of materials without their damaging)
- IT Glass, processes
RL: PEP (Physical, engineering or chemical process); PYP (Physical process); PROC (Process)
(marking of; apparatus for highly visible laser marking of materials without their damaging)
- L7 ANSWER 5 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
- AN 2001:907640 CAPLUS
- DN 136:207283
- ED Entered STN: 17 Dec 2001
- TI Interplay between self-focusing and high-order **multiphoton** absorption
- AU Polyakov, Sergey; Yoshino, Fumiyo; Stegeman, George
- CS School of Optics and Center for Research and Education in Optics and Lasers, University of Central Florida, Orlando, FL, 32816, USA
- SO Journal of the Optical Society of America B: Optical Physics (2001), 18(12), 1891-1895
CODEN: JOBPDE; ISSN: 0740-3224
- PB Optical Society of America
- DT Journal
- LA English
- CC 73-11 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
- AB The authors study the distortion of optical beams that is due to the combined effects of strong self-focusing and 3- and 4-photon absorption, a situation that exists, for example, in the polydiacetylene bis-paratoluene sulfonate (PTS). The characteristic nonlinear distances were defined for each process. Theor. anal. of the beam propagation leads to 2 distinct limits, 1 limit dominated by self-focusing and the other by higher-order absorption. Propagation was studied anal. and numerically for continuous-wave and pulsed beams in these 2 limits and for cases in which both nonlinear effects are important. Beam distortion caused by **multiphoton** absorption and **refraction** leads to situations in which **diffraction** plays an important role, even for input beams whose **diffraction** length is much larger than the sample length. For the typical intensities used in Z-scan measurements, nonlinear processes and **diffraction** contribute simultaneously to beam distortion and must be taken into account.

STN search for 10/622488

ST interplay focusing multiphoton absorption
IT Optical absorption
(interplay between self-focusing and high-order multiphoton absorption)
IT 32535-60-7
RL: PRP (Properties)
(interplay between self-focusing and high-order multiphoton absorption)

RE.CNT 18 THERE ARE 18 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE

- (1) Boyd, R; Nonlinear Optics 1992
- (2) Bradley, D; Proc IEEE 1974, V62, P313
- (3) Chi, S; Opt Lett 1995, V20, P1598
- (4) Chiao, R; Phys Rev Lett 1964, V13, P479
- (5) Denk, W; Science 1990, V248, P73 CAPLUS
- (6) Eckstein, J; Phys Rev Lett 1978, V40, P847 CAPLUS
- (7) Garito, A; Handbook of Laser Science and Technology 1995, Suppl 1, P329
- (8) Gora, V; Izv Akad Nauk Fiz 1981, V45, P983
- (9) Lawrence, B; Opt Lett 1998, V8, P591
- (10) Parthenopoulos, D; J Appl Phys 1990, V68, P5814 CAPLUS
- (11) Polyakov, S; J Nonlin Opt (to be published)
- (12) Sheik-Bahae, M; IEEE J Quantum Electron 1990, V26, P760 CAPLUS
- (13) Stegeman, G; Contemporary Nonlinear Optics 1992
- (14) Tannermann, A; Opt Lett 1991, V16, P402
- (15) Van Stryland, E; Handbook of Laser Science and Technology 1995, Suppl 1, P299
- (16) Van Stryland, E; J Opt Soc Am B 1988, V5, P1980 CAPLUS
- (17) Vinogradova, M; Wave Theory, 2nd ed (in Russian) 1990
- (18) Yoshino, F; J Nonlinear Opt Phys Mater 2000, V9, P95 CAPLUS

L7 ANSWER 6 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2001:734065 CAPLUS
DN 135:296267
ED Entered STN: 09 Oct 2001
TI Method of making visible marks in a transparent material by laser beam radiation, marking apparatus, and transparent optical member marked by the method
IN Hayashi, Kenichi; Ito, Kazuyoshi
PA Sumitomo Heavy Industries, Ltd., Japan
SO Jpn. Kokai Tokkyo Koho, 9 pp.
CODEN: JKXXAF
DT Patent
LA Japanese
IC ICM B23K026-00
ICS B23K026-00; B23K026-04; B23K026-08; C03C023-00; G02B005-18
CC 74-13 (Radiation Chemistry, Photochemistry, and Photographic and Other Reprographic Processes)
Section cross-reference(s): 73
FAN.CNT 1

	PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
PI	JP 2001276985	A2	20011009	JP 2000-258854	20000829
	JP 3522671	B2	20040426		
	US 2002041323	A1	20020411	US 2001-940604	20010829
	US 6621041	B2	20030916		
PRAI	JP 2000-19062	A	20000127		
	JP 2000-258854	A	20000829		

CLASS

PATENT NO.	CLASS	PATENT FAMILY CLASSIFICATION CODES
------------	-------	------------------------------------

STN search for 10/622488

JP 2001276985 ICM B23K026-00
ICS B23K026-00; B23K026-04; B23K026-08; C03C023-00;
G02B005-18
US 2002041323 ECLA G02B005/18M2

AB In marking a transparent material, a laser beam of wavelength capable of transmitting the material is focused on inner part of the transparent material to allow **multiphoton** absorption and cause n changes, and the focal point of the laser beam is so moved as to form a **diffraction** pattern which **diffracts** a visible ray. An optically marking apparatus is equipped with a stage for loading the material, a light source emitting the laser beam, an optical system for focusing the laser beam, and a means of moving the focal point to form the **diffraction** grating. A transparent optical member, marked by the method, has the **diffraction** pattern inside. Alternatively, a method of marking marks in a material comprises the following steps; (1) irradiating the material with a pulsed laser beam by changing NA of an object lens and energy intensity per one pulse (EI) to form optically modified region, (2) determining a function of NA, EI, and length of modified region (LE), (3) determining NA and EI from the required LE by using the function, and (4) irradiating the laser beam to form the modified region. The marking method does not cause damage or drop in strength of the material, and the formed mark can be easily recognized without using a readout apparatus

ST transparent material marking laser radiation n change; **diffraction** grating formation laser radiation transparent material marking; **multiphoton** absorption laser induced **diffraction** grating marking; glass marking laser induced **diffraction** grating

IT **Refractive index**
(changes; making visible marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

IT **Multiphoton absorption**
(laser radiation; making visible marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

IT Laser induced grating
Marking
Transparent materials
(making visible marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

IT Laser radiation
(pulsed; making visible marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

IT Glass substrates
(transparent; making visible marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

L7 ANSWER 7 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN

AN 2001:243986 CAPLUS

DN 135:26571

ED Entered STN: 06 Apr 2001

TI Arbitrary-lattice photonic crystals created by **multiphoton** micro-fabrication

AU Sun, Hong-Bo; Xu, Ying; Juodkazis, Saulius; Sun, Kai; Watanabe, Mitsuru; Matsuo, Shigeki; Misawa, Hiroaki; Nishii, Junji

CS Satellite Venture Business Laboratory, The University of Tokushima, Tokushima, 770-8506, Japan

SO Optics Letters (2001), 26(6), 325-327

CODEN: OPLEDP; ISSN: 0146-9592

PB Optical Society of America

STN search for 10/622488

DT Journal
LA English
CC 73-10 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
AB The authors used voxels of an intensely modified **refractive** index generated by **multiphoton** absorption at the focus of femtosecond laser pulses in Ge-doped SiO₂ as photonic atoms to build photonic lattices. The voxels were spatially organized in the same way as atoms arrayed in actual crystals, and a Bragg-like **diffraction** from the photonic atoms was evidenced by a photonic bandgap (PBG) effect. Post-fabrication annealing is essential for reducing random scattering and therefore enhancing PBG. This technique has an intrinsic capability of individually addressing single atoms. Therefore the introduction of defect structures was much facilitated, making the technique quite appealing for photonic research and applications.
ST photonic crystal **multiphoton** microfabrication
IT Annealing
Band gap
Multiphoton absorption
Optical diffraction
Optical refraction
Photonic crystals
Photonics
Solid state lasers
(arbitrary-lattice photonic crystals created by **multiphoton** micro-fabrication)
IT 7631-86-9, Silica, uses
RL: DEV (Device component use); MOA (Modifier or additive use); USES (Uses)
(arbitrary-lattice photonic crystals created by **multiphoton** micro-fabrication)
IT 1310-53-8, Germanium oxide (GeO₂), uses 7440-56-4, Germanium, uses 13463-67-7, Titania, uses
RL: MOA (Modifier or additive use); USES (Uses)
(arbitrary-lattice photonic crystals created by **multiphoton** micro-fabrication)
RE.CNT 17 THERE ARE 17 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE
(1) Bell, P; Comp Phys Commun 1995, V85, P306 CAPLUS
(2) Blanco, A; Nature 2000, V405, P437 CAPLUS
(3) Busch, K; Phys Rev Lett 1999, V83, P967 CAPLUS
(4) Day, D; Opt Lett 1999, V24, P948 CAPLUS
(5) Glezer, E; Appl Phys Lett 1997, V71, P882 CAPLUS
(6) Glezer, E; Opt Lett 1996, V21, P2023 CAPLUS
(7) Joannopoulos, J; Nature 1997, V386, P143 CAPLUS
(8) Maruo, S; Opt Lett 1997, V22, P132 CAPLUS
(9) Miura, K; Appl Phys Lett 1997, V71, P3329 CAPLUS
(10) Strickler, J; Opt Lett 1991, V16, P1780 CAPLUS
(11) Sun, H; Appl Phys Lett 1999, V74, P786 CAPLUS
(12) Sun, H; J Phys Chem B 2000, V104, P3450 CAPLUS
(13) Sun, H; Opt Rev 1999, V6, P396 CAPLUS
(14) Ueki, H; Appl Opt 1996, V35, P2456
(15) Watanabe, M; Appl Phys Lett 2000, V77, P13 CAPLUS
(16) Watanabe, M; Phys Rev B 1999, V60, P9959 CAPLUS
(17) Yablonovitch, E; Phys Rev Lett 1987, V58, P2059 CAPLUS
L7 ANSWER 8 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1999:535149 CAPLUS
DN 131:264484
ED Entered STN: 26 Aug 1999

STN search for 10/622488

- TI Enhanced photosensitivity in germanosilicate fibers exposed to CO2 laser radiation
- AU Brambilla, G.; Pruner, V.; Reekie, L.; Payne, D. N.
- CS Optoelectronics Research Centre, Southampton University, Southampton, SO17-1BJ, UK
- SO Optics Letters (1999), 24(15), 1023-1025
CODEN: OPLEDP; ISSN: 0146-9592
- PB Optical Society of America
- DT Journal
- LA English
- CC 73-11 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
Section cross-reference(s): 57, 74
- AB The authors report a novel method to increase the UV photosensitivity of GeO2:SiO2 optical fibers based on exposure to CO2 laser irradiation before grating writing. Fibers treated with a CO2 laser can produce gratings with refractive-index modulation 2 times greater and a Bragg wavelength that can be 2 nm longer than those of untreated fibers. Expts. on GeO2:SiO2 preform samples treated with a CO2 laser in a way similar to the fibers showed a marked increase of the 242-nm absorption band, which is associated with an increase of Ge O-deficient centers and is believed to be responsible for the higher photorefractive response.
- ST photosensitivity germanosilicate optical fiber carbon dioxide laser radiation; **diffraction** grating germanosilicate optical fiber photosensitivity laser irradiation; **multiphoton** absorption germanosilicate optical fiber photosensitivity laser irradiation; photorefractive germanosilicate optical fiber photosensitivity laser irradiation; near IR reflection germanosilicate optical fiber **diffraction** grating photosensitivity; UV optical fiber preform photosensitivity laser irradiation
- IT **Diffraction** gratings
Laser radiation
Multiphoton absorption
Optical fibers
Photorefractive effect
UV and visible spectra
(enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)
- IT IR reflectance spectra
(near-IR; enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)
- IT Germanosilicate glasses
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)
(optical fibers; enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)
- IT Glass fibers, properties
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)
(optical germanosilicate; enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)
- IT Defects in solids
(oxygen-deficient; enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)
- IT 1310-53-8, Germania, properties 60676-86-0, Vitreous silica
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)

STN search for 10/622488

(enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)

RE.CNT 12 THERE ARE 12 CITED REFERENCES AVAILABLE FOR THIS RECORD

RE

- (1) Bilodeau, F; Opt Lett 1993, V18, P953 CAPLUS
- (2) Byron, K; US 5694502 1997
- (3) Dong, L; IEEE Photon Technol Lett 1995, V7, P1048
- (4) Douay, M; Ann Telecommun 1997, V52, P543
- (5) Hill, K; Appl Phys Lett 1978, V32, P647
- (6) Hill, K; Optical Fiber Communication 1991, V1, P14
- (7) Hosono, H; Phys Rev B 1992, V46, P11445 CAPLUS
- (8) Lee, J; J Non-Cryst Solids 1998, V239, P57 CAPLUS
- (9) Lemaire, P; Electron Lett 1993, V29, P1191 CAPLUS
- (10) Othonos, A; Rev Sci Instrum 1997, V68, P4309 CAPLUS
- (11) Takahashi, M; Appl Phys Lett 1998, V72, P1287 CAPLUS
- (12) Williams, D; Electron Lett 1993, V29, P45

L7 ANSWER 9 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN

AN 1974:483774 CAPLUS

DN 81:83774

ED Entered STN: 12 May 1984

TI **Multiphoton** photorefractive processes for optical storage in lithium niobate(V)

AU Von der Linde, D.; Glass, A. M.; Rodgers, K. F.

CS Bell Lab., Murray Hill, NJ, USA

SO Applied Physics Letters (1974), 25(3), 155-7

CODEN: APPLAB; ISSN: 0003-6951

DT Journal

LA English

CC 73-2 (Spectra by Absorption, Emission, Reflection, or Magnetic Resonance, and Other Optical Properties)

AB Permanent reversible changes of the n of pure and doped LiNbO₃ were obtained by **multiphoton** absorption. Greatly increased sensitivity over the linear process enables holograms to be recorded even in high-purity LiNbO₃, with a **diffraction** efficiency of 25% with less than 0.4 J/cm². These holograms can be read nondestructively, eliminating the need for fixing processes while the versatility of optical erasure is maintained.

ST **multiphoton** lithium niobate **refraction**; hologram
lithium niobate **multiphoton**

IT Photon
(absorption of many, lithium niobate **refractive** index change in)

IT Holography
(lithium niobate **multiphoton** photorefractive process in)

IT **Refractive** index and **Refraction**
(permanent reversible changes of, by **multiphoton** absorption)

IT 12031-63-9

RL: USES (Uses)

(**multiphoton** photorefractive change of, in holog.)

=> d his

(FILE 'HOME' ENTERED AT 10:55:31 ON 26 OCT 2004)

FILE 'CAPLUS' ENTERED AT 10:55:46 ON 26 OCT 2004

L1 13877 S (MULTIPHOTON OR MULTIPLE PHOTON)

L2 81 S L1 AND REFRACTIVE

L3 109 S L1 AND REFRACT?

STN search for 10/622488

L4 11 S L3 AND VISIBLE
L5 109 S (MULTIPHOTON OR MULTIPLE PHOTON) AND REFRACT?
L6 106 S (MULTIPHOTON OR MULTIPLE PHOTON) AND DIFFRACT?
L7 9 S L5 AND L6

=> s 17 and visibl?

289564 VISIBL?

L8 3 L7 AND VISIBL?

=> d all 1-3

L8 ANSWER 1 OF 3 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2002:160423 CAPLUS
DN 136:207766
ED Entered STN: 05 Mar 2002
TI Method and apparatus for laser marking and marked optical materials
IN Hayashi, Kenichi
PA Sumitomo Heavy Industries, Ltd., Japan
SO Jpn. Kokai Tokkyo Koho, 5 pp.
CODEN: JKXXAF
DT Patent
LA Japanese
IC ICM B23K026-00
ICS B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18;
G02B005-32
CC 74-8 (Radiation Chemistry, Photochemistry, and Photographic and Other
Reprographic Processes)
Section cross-reference(s): 73
FAN.CNT 1

	PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
PI	JP 2002066769	A2	20020305	JP 2000-257182	20000828
	JP 3522670	B2	20040426		
PRAI	JP 2000-257182		20000828		

PATENT NO.	CLASS	PATENT FAMILY CLASSIFICATION CODES
JP 2002066769	ICM	B23K026-00
	ICS	B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18; G02B005-32

AB The apparatus comprises a laser beam source, a hologram plate, an optical scanning system for deflection of the **diffraction** beams, an optical focusing system for convergence of the **diffraction** beams, and a stage for placing the marking substrate at the positions where the **diffraction** beams are converged. Marking of materials by forming multiple nos. of points having varied **refractive** index caused by **multiphoton** absorption is claimed. Optical materials marked with patterns that **diffract visible** light and method for marking are also claimed. Easily **visible** markings are formed without damaging the marked materials.

ST laser marking app optical material; **multiphoton** absorption laser marking; grating laser induced marking holog

IT Holographic **diffraction** gratings
Laser induced grating
(apparatus for highly **visible** laser marking of materials without their damaging)

IT Marking
(laser; apparatus for highly **visible** laser marking of materials without their damaging)

IT **Multiphoton** absorption

STN search for10/622488

(marking by; apparatus for highly **visible** laser marking of materials without their damaging)

IT Glass, processes
RL: PEP (Physical, engineering or chemical process); PYP (Physical process); PROC (Process)
(marking of; apparatus for highly **visible** laser marking of materials without their damaging)

L8 ANSWER 2 OF 3 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2001:734065 CAPLUS
DN 135:296267
ED Entered STN: 09 Oct 2001
TI Method of making **visible** marks in a transparent material by laser beam radiation, marking apparatus, and transparent optical member marked by the method
IN Hayashi, Kenichi; Ito, Kazuyoshi
PA Sumitomo Heavy Industries, Ltd., Japan
SO Jpn. Kokai Tokkyo Koho, 9 pp.
CODEN: JKXXAF
DT Patent
LA Japanese
IC ICM B23K026-00
ICS B23K026-00; B23K026-04; B23K026-08; C03C023-00; G02B005-18
CC 74-13 (Radiation Chemistry, Photochemistry, and Photographic and Other Reprographic Processes)
Section cross-reference(s): 73
FAN.CNT 1

	PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
PI	JP 2001276985	A2	20011009	JP 2000-258854	20000829
	JP 3522671	B2	20040426		
	US 2002041323	A1	20020411	US 2001-940604	20010829
	US 6621041	B2	20030916		
PRAI	JP 2000-19062	A	20000127		
	JP 2000-258854	A	20000829		

CLASS

PATENT NO.	CLASS	PATENT FAMILY CLASSIFICATION CODES
JP 2001276985	ICM	B23K026-00
	ICS	B23K026-00; B23K026-04; B23K026-08; C03C023-00; G02B005-18
US 2002041323	ECLA	G02B005/18M2

AB In marking a transparent material, a laser beam of wavelength capable of transmitting the material is focused on inner part of the transparent material to allow **multiphoton** absorption and cause n changes, and the focal point of the laser beam is so moved as to form a **diffraction** pattern which **diffracts** a **visible** ray. An optically marking apparatus is equipped with a stage for loading the material, a light source emitting the laser beam, an optical system for focusing the laser beam, and a means of moving the focal point to form the **diffraction** grating. A transparent optical member, marked by the method, has the **diffraction** pattern inside. Alternatively, a method of marking marks in a material comprises the following steps; (1) irradiating the material with a pulsed laser beam by changing NA of an object lens and energy intensity per one pulse (EI) to form optically modified region, (2) determining a function of NA, EI, and length of modified region (LE), (3) determining NA and EI from the required LE by using the function, and (4) irradiating the laser beam to form the modified region. The marking method does not cause damage or drop in strength of the material, and the formed mark can be easily recognized without using a

STN search for 10/622488

- readout apparatus
- ST transparent material marking laser radiation n change; **diffraction** grating formation laser radiation transparent material marking; **multiphoton** absorption laser induced **diffraction** grating marking; glass marking laser induced **diffraction** grating
- IT **Refractive** index
(changes; making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)
- IT **Multiphoton** absorption
(laser radiation; making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)
- IT Laser induced grating
Marking
Transparent materials
(making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)
- IT Laser radiation
(pulsed; making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)
- IT Glass substrates
(transparent; making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)
- L8 ANSWER 3 OF 3 CAPLUS COPYRIGHT 2004 ACS on STN
- AN 1999:535149 CAPLUS
- DN 131:264484
- ED Entered STN: 26 Aug 1999
- TI Enhanced photosensitivity in germanosilicate fibers exposed to CO2 laser radiation
- AU Brambilla, G.; Pruneri, V.; Reekie, L.; Payne, D. N.
- CS Optoelectronics Research Centre, Southampton University, Southampton, SO17-1BJ, UK
- SO Optics Letters (1999), 24(15), 1023-1025
CODEN: OPLEDP; ISSN: 0146-9592
- PB Optical Society of America
- DT Journal
- LA English
- CC 73-11 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
Section cross-reference(s): 57, 74
- AB The authors report a novel method to increase the UV photosensitivity of GeO2:SiO2 optical fibers based on exposure to CO2 laser irradiation before grating writing. Fibers treated with a CO2 laser can produce gratings with **refractive**-index modulation 2 times greater and a Bragg wavelength that can be 2 nm longer than those of untreated fibers. Expts. on GeO2:SiO2 preform samples treated with a CO2 laser in a way similar to the fibers showed a marked increase of the 242-nm absorption band, which is associated with an increase of Ge O-deficient centers and is believed to be responsible for the higher photorefractive response.
- ST photosensitivity germanosilicate optical fiber carbon dioxide laser radiation; **diffraction** grating germanosilicate optical fiber photosensitivity laser irradiation; **multiphoton** absorption germanosilicate optical fiber photosensitivity laser irradiation; photorefractive germanosilicate optical fiber photosensitivity laser irradiation; near IR reflection germanosilicate optical fiber **diffraction** grating photosensitivity; UV optical fiber preform

STN search for 10/622488

photosensitivity laser irradiation
IT **Diffraction gratings**
Laser radiation
Multiphoton absorption
Optical fibers
Photorefractive effect
UV and **visible** spectra
(enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)
IT IR reflectance spectra
(near-IR; enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)
IT Germanosilicate glasses
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)
(optical fibers; enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)
IT Glass fibers, properties
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)
(optical germanosilicate; enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)
IT Defects in solids
(oxygen-deficient; enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)
IT 1310-53-8, Germania, properties 60676-86-0, Vitreous silica
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)
(enhanced photosensitivity in germanosilicate optical fibers exposed to CO2 laser radiation with **diffraction** gratings)
RE.CNT 12 THERE ARE 12 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE
(1) Bilodeau, F; Opt Lett 1993, V18, P953 CAPLUS
(2) Byron, K; US 5694502 1997
(3) Dong, L; IEEE Photon Technol Lett 1995, V7, P1048
(4) Douay, M; Ann Telecommun 1997, V52, P543
(5) Hill, K; Appl Phys Lett 1978, V32, P647
(6) Hill, K; Optical Fiber Communication 1991, V1, P14
(7) Hosono, H; Phys Rev B 1992, V46, P11445 CAPLUS
(8) Lee, J; J Non-Cryst Solids 1998, V239, P57 CAPLUS
(9) Lemaire, P; Electron Lett 1993, V29, P1191 CAPLUS
(10) Othonos, A; Rev Sci Instrum 1997, V68, P4309 CAPLUS
(11) Takahashi, M; Appl Phys Lett 1998, V72, P1287 CAPLUS
(12) Williams, D; Electron Lett 1993, V29, P45

=> log y

COST IN U.S. DOLLARS

SINCE FILE	TOTAL
ENTRY	SESSION
94.84	95.05

FULL ESTIMATED COST

DISCOUNT AMOUNTS (FOR QUALIFYING ACCOUNTS)

SINCE FILE	TOTAL
ENTRY	SESSION
-16.10	-16.10

CA SUBSCRIBER PRICE

STN INTERNATIONAL LOGOFF AT 10:57:58 ON 26 OCT 2004

STN search for 10/622488